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		A.B	4	2	4	6	5	8	5	01/1981	Mailloux		343	854		09/1979	
		A.C	4	3	6	0	8	1	3	11/1982	Fitzsimmons		343	100		03/1980	
		A.D	4	5	6	6	0	1	3	01/1986	Steinberg et al.		343	372		04/1983	
		A.E	4	6	0	7	3	8	9	08/1986	Halgrimson		455	11		02/1984	
		A.F	4	6	1	4	9	4	7	09/1986	Rammos		343	778		04/1984	
		A.G	4	6	8	9	6	3	1	08/1987	Gans et al.		343	781		05/1985	
		A.H	4	8	2	5	1	7	2	04/1989	Thompson	nompson				03/1987	
		A.I	4	8	4	9	7	6	3	07/1989	DuFort		342	372	_	04/1987	
		A.J	4	8	9	0	1	1	0	12/1989	Kuwahara		342	35		12/1988	
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	B.F	5	2	4	8	9	8	0	09/1993	Raguenet		342	354		04/1992		
	B.G	5	2	7	0	7	2	1	12/1993	Tsukamoto et al.		343	700		04/1992		
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	B.I	5	3	2	7	1	5	0	07/1994	Cherrette		343 771			03/1993		
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Substitute Disclosure Form (PTO-1449)

Sheet <u>3 (C)</u> of _ SERIAL NO. SUBSTITUTE FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE ATTY. DOCKET NO. ANCO/25US 09/998.873 PATENT AND TRADEMARK OFFICE (MODIFIE FORMATION DISCLOSURE STATEMENT BY APPLICANT **APPLICANT** Mike Thomas and Mano D. Judd FILING DATE **GROUP** several sheets if necessary) October 31, 2001 2821 (37 C) U.S. PATENT DOCUMENTS FILING DATE **ISSUE EXAMINER CLASS SUBCLASS** PATENT NUMBER DATE **PATENTEE** INITIAL APPROPRIATE 04/1988 05/1995 174 To 2 342 4 Ast et al. C.A 10/1995 01/1994 359 121 C.B 5 4 5 7 5 5 Zarem et al. 7 04/1996 370 18 08/1993 5 1 Dean et al. C.C 1 3 03/1994 08/1996 455 33.3 5 8 3 Charas et al. C.D 5 8 1 06/1995 5 5 8 6 09/1996 Larson 257 275 C.E 5 778 02/1995 10/1996 Collins 343 5 5 8 1 6 O C.F 6 374 08/1994 9 3 2 9 01/1997 Searle et al. 342 5 5 6 C.G 330 124 11/1995 5 0 4 4 6 2 02/1997 Gans et al. C.H 6 5 03/1997 324 95 06/1996 5 0 1 0 Boone et al. 6 C.I 04/1994 9 2 0 04/1997 342 352 5 6 1 1 Dent C.J 354 02/1995 5 6 3 2 9 04/1997 Hirshfield et al. 342 C.K 2 6 FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS TRANSLATION **PUBLICATION** COUNTRY OR DOCUMENT **SUBCLASS** (YES/NO) PATENT OFFICE **CLASS** NUMBER DATE C.L C.M C.N C.O C.P C.Q OTHER DOCUMENTS (Including Author, Title, Date, Place of Publication) C.R C.S C.T

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	E.C	5	8	0	9						t al.	455	4.1		06/1995	
	E.D	5	8	2	5	7	6	2	10/1998	Kamin, Jr. et al.		370	335	-	09/1996	
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	E.F	5	8	5	4	6	1	1	12/1998	Gans et al.		342	373		07/1995	
	E.G	5	8	5	6	8	0	4	01/1999	Turcotte et al.		342	371		10/1996	
	E.H	5	8	6	2	4	5	9	01/1999	Charas		455	114		08/1996	
	E.I	5	8	7	8	3	4	5	03/1999	Ray et al.		455	431		09/1996	
	E.J	5	9	3	6	5	7	7	08/1999	Shoki et al.		342	373		10/1997	
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		F.B	3 6 0 0 8 7 6					6	3	12/1999	Nystro	om et al.		343	700		05/1997	
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		F.D	- 						3	01/2000	Golem	non et al.		455	63		06/1997	
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		F.G	6	0	7	2	4	3	4	06/2000	Papati	heodorou		343	700		02/1997	
		F.H	6	0	9	1	3	6	0	07/2000	Reits			342	368		07/1998	
		F.I	6	0	9	4	1	6	5	07/2000	Smith	1	1	342	373		07/1997	
		F.J	6	1	0	4	9	3	5	08/2000	Smith	et al.		455	562		05/1997	
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ط	G.A	6	1	4	4	6	5	2	11/2000	Avidor et al.		370	336		11/1996	
	G.B	6	1	5	7	3	4	3	12/2000	Andersson et al.		342	371		04/1997	
	G.C	6	1	6	0	5	1	4	12/2000	Judd		343	700		10/1999	
	G.D	6	2	2	2	5	0	3	04/2001	Gietema et al.		343	890		01/1998	
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